Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/813,989	DAVIS ET AL.
Examiner	Art Unit

Alan S. Chen

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SEARCHED						
Class	Subclass	Date	Examiner			
710	5	11/21/2006	ASC			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT PLUS; Inventor Search	11/21/2006	ASC			
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